


<b>Search Notes</b> 	<b>Application/Control No.</b> 10577959	<b>Applicant(s)/Patent Under Reexamination</b> TAKAHASHI ET AL.
	<b>Examiner</b> Lee S Cohen	<b>Art Unit</b> 3739

SEARCHED			
Class	Subclass	Date	Examiner
600	393	5/28/08	LSC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	5/28/08	LSC

INTERFERENCE SEARCH			
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